

# PRELIMINARY

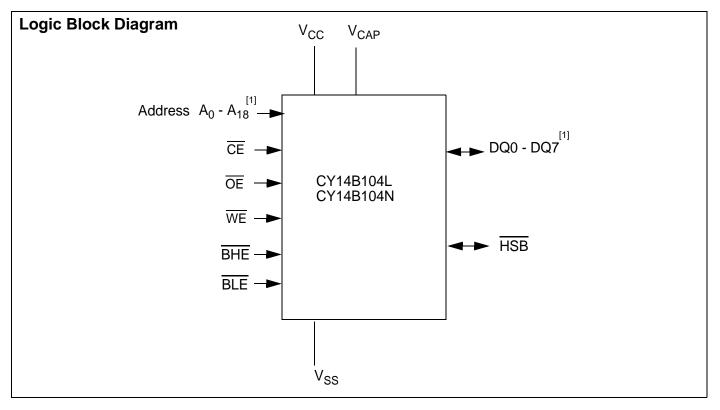
# CY14B104L, CY14B104N 4 Mbit (512K x 8/256K x 16) nvSRAM

#### Features

- 15 ns, 20 ns, 25 ns, and 45 ns access times
- Internally organized as 512K x 8 (CY14B104L) or 256K x 16 (CY14B104N)
- Hands off automatic STORE on power down with only a small capacitor
- STORE to QuantumTrap<sup>®</sup> nonvolatile elements initiated by software, device pin, or AutoStore<sup>®</sup> on power down
- RECALL to SRAM initiated by software or power up
- Infinite read, write, and recall cycles
- 200,000 STORE cycles to QuantumTrap
- 20 year data retention
- Single 3V +20%, -10% operation
- Commercial and industrial temperatures
- 48-pin FBGA and 44/54-pin TSOP II packages
- Pb-free and RoHS compliance

### **Functional Description**

The Cypress CY14B104L/CY14B104N is a fast static RAM, with a nonvolatile element in each memory cell. The memory is organized as 512K words of 8 bits each or 256K words of 16 bits each. The embedded nonvolatile elements incorporate QuantumTrap technology, producing the world's most reliable nonvolatile memory. The SRAM provides infinite read and write cycles, while independent nonvolatile data resides in the highly reliable QuantumTrap cell. Data transfers from the SRAM to the nonvolatile elements (the STORE operation) takes place automatically at power down. On power up, data is restored to the SRAM (the RECALL operation) from the nonvolatile memory. Both the STORE and RECALL operations are also available under software control.



#### Note

1. Address A<sub>0</sub> - A<sub>18</sub> and Data DQ0 - DQ7 for x8 configuration, Address A<sub>0</sub> - A<sub>17</sub> and Data DQ0 - DQ15 for x16 configuration.

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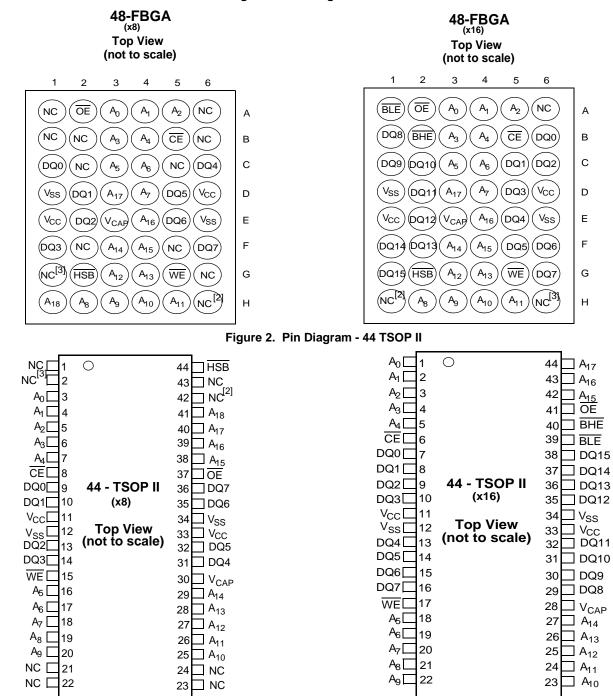
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#### **Pinouts**

Figure 1. Pin Diagram - 48 FBGA



#### Notes

2. Address expansion for 8 Mbit. NC pin not connected to die.

3. Address expansion for 16 Mbit. NC pin not connected to die.



# Pinouts (continued)

#### Figure 3. Pin Diagram - 54 Pin TSOP II (x16)

| $\begin{array}{c c c c c c c c c c c c c c c c c c c $ | 54       HSB         53       NC <sup>[2]</sup> 52       A <sub>17</sub> 51       A <sub>16</sub> 50       A <sub>15</sub> 49       OE         48       BHE         47       BLE         46       DQ15         45       DQ14         44       DQ13         43       DQ12         42       V <sub>SS</sub> 41       V <sub>CC</sub> 40       DQ10         38       DQ9         37       DQ8         36       V <sub>CAP</sub> 35       A <sub>14</sub> 34       A <sub>13</sub> 33       A <sub>12</sub> 32       A <sub>11</sub> 31       A <sub>10</sub> 30       NC         28       NC |
|--|---|
|--|---|

# **Pin Definitions**

| Pin Name         | Ю Туре       | Description   |
|------------------|--------------|---|
| $A_0 - A_{18}$   | Input        | Address Inputs Used to Select one of the 524, 288 bytes of the nvSRAM for x8 Configuration.   |
| $A_0 - A_{17}$   |              | Address Inputs Used to Select one of the 262,144 bytes of the nvSRAM for x16 Configuration.   |
| DQ0 – DQ7        | Input/Output | Bidirectional Data IO Lines for x8 Configuration. Used as input or output lines depending on operation.   |
| DQ0 – DQ15       |              | Bidirectional Data IO Lines for x16 Configuration. Used as input or output lines depending on operation.  |
| WE               | Input        | Write Enable Input, Active LOW. When selected LOW, data on the IO pins is written to the address location latched by the falling edge of CE.  |
| CE               | Input        | Chip Enable Input, Active LOW. When LOW, selects the chip. When HIGH, deselects the chip.   |
| ŌĒ               | Input        | Output Enable, Active LOW. The active LOW OE input enables the data output buffers during read cycles. IO pins are tri-stated on deasserting OE HIGH.   |
| BHE              | Input        | Byte High Enable, Active LOW. Controls DQ15 - DQ8.  |
| BLE              | Input        | Byte Low Enable, Active LOW. Controls DQ7 - DQ0.  |
| V <sub>SS</sub>  | Ground       | Ground for the Device. Must be connected to the ground of the system.   |
| V <sub>CC</sub>  | Power Supply | Power Supply Inputs to the Device.  |
| HSB              | Input/Output | <b>Hardware Store Busy (HSB)</b> . When LOW this output indicates that a hardware store is in progress. When pulled LOW external to the chip it initiates a nonvolatile STORE operation. A weak internal pull up resistor keeps this pin HIGH if not connected (connection optional). |
| V <sub>CAP</sub> | Power Supply | AutoStore Capacitor. Supplies power to the nvSRAM during power loss to store data from SRAM to nonvolatile elements.  |
| NC               | No Connect   | No Connect. Do not connect this pin to the die.   |

PRELIMINARY



### **Device Operation**

The CY14B104L/CY14B104N nvSRAM is made up of two functional components paired in the same physical cell. They are an SRAM memory cell and a nonvolatile QuantumTrap cell. The SRAM memory cell operates as a standard fast static RAM. Data in the SRAM is transferred to the nonvolatile cell (the STORE operation), or from the nonvolatile cell to the SRAM (the RECALL operation). Using this unique architecture, all cells are stored and recalled in parallel. During the STORE and RECALL operations, SRAM read and write operations are inhibited. The CY14B104L/CY14B104N supports infinite reads and writes similar to a typical SRAM. In addition, it provides infinite RECALL operations.

### SRAM Read

The <u>CY</u>14B104L/CY14B104N performs a read cycle when CE and OE are LOW and WE and HSB are HIGH. The address specified on pins  $A_{0-18}$  or  $A_{0-17}$  determines which of the 524,288 data bytes or 262,144 words of 16 bits each are accessed. When the read is initiated by an address transition, the outputs are valid after a delay of  $t_{AA}$  (read cycle #1). If the read is initiated by CE or OE, the outputs are valid at  $t_{ACE}$  or at  $t_{DOE}$ , whichever is later (read cycle #2). The data output repeatedly responds to address changes within the  $t_{AA}$  access time without the need for transitions on any control input pins. This remains valid until another address change or until CE or OE is brought HIGH, or WE or HSB is brought LOW.

#### SRAM Write

A write cycle is performed when  $\overline{CE}$  and  $\overline{WE}$  are LOW and  $\overline{HSB}$  is HIGH. The address inputs must be stable before entering the write cycle and must remain stable until  $\overline{CE}$  or  $\overline{WE}$  goes HIGH at the end of the cycle. The data on the common IO pins  $DQ_{0-15}$  are written into the memory if the data is valid  $t_{SD}$  before the end of a WE controlled write or before the end of an  $\overline{CE}$  controlled write. It is recommended that  $\overline{OE}$  be kept HIGH during the entire write cycle to avoid data bus contention on common IO lines. If  $\overline{OE}$  is left LOW, internal circuitry turns off the output buffers  $t_{HZWE}$  after  $\overline{WE}$  goes LOW.

#### AutoStore Operation

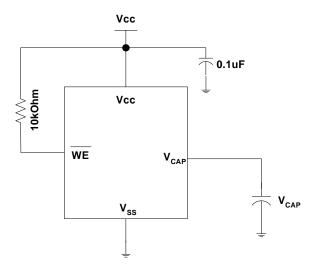
The CY14B104L/CY14B104N stores data to the nvSRAM using one of the following three storage operations: Hardware Store activated by HSB; Software Store activated by an address sequence; AutoStore on device power down. The AutoStore operation is a unique feature of QuantumTrap technology and is enabled by default on the CY14B104L/CY14B104N.

During a normal operation, the device draws current from V<sub>CC</sub> to charge a capacitor connected to the V<sub>CAP</sub> pin. This stored charge is used by the chip to perform a single STORE operation. If the voltage on the V<sub>CC</sub> pin drops below V<sub>SWITCH</sub>, the part automatically disconnects the V<sub>CAP</sub> pin from V<sub>CC</sub>. A STORE operation is initiated with power provided by the V<sub>CAP</sub> capacitor.

Figure 4 shows the proper connection of the storage capacitor (V<sub>CAP</sub>) for automatic store operation. Refer to DC Electrical Characteristics on page 7 for the size of V<sub>CAP</sub>.

To reduce unnecessary nonvolatile stores, AutoStore and hardware store operations are ignored unless at least one write operation has taken place since the most recent STORE or RECALL cycle. Software initiated STORE cycles are performed regardless of whether a write operation has taken place. The HSB signal is monitored by the system to detect if an AutoStore cycle is in progress.

#### Figure 4. AutoStore Mode



### Hardware STORE Operation

The CY14B104L/CY14B104N provides the HSB pin to control and acknowledge the STORE operations. Use the HSB pin to request a hardware STORE cycle. When the HSB pin is driven LOW, the CY14B104L/CY14B104N conditionally initiates a STORE operation after  $t_{DELAY}$ . An actual STORE cycle only begins if a write to the SRAM has taken place since the last STORE or RECALL cycle. The HSB pin also acts as an open drain driver that is internally driven LOW to indicate a busy condition when the STORE (initiated by any means) is in progress.

SRAM read and write operations that are in progress when HSB is driven LOW by any means are given time to complete before the STORE operation is initiated. After HSB goes LOW, the CY14B104L/CY14B104N continues SRAM operations for t<sub>DELAY</sub>. During t<sub>DELAY</sub>, multiple SRAM read operations may take place. If a write is in progress when HSB is pulled low it is allowed a time, t<sub>DELAY</sub> to complete. However, any SRAM write cycles requested after HSB goes LOW are inhibited until HSB returns HIGH.

During any STORE operation, regardless of how it is <u>initiated</u>, the CY14B104L/CY14B104N continues to drive the HSB pin LOW,releasing it only when the STORE is complete.Upon completion of the STORE operation, the CY14B104L/CY14B104N remains disabled until the HSB pin returns HIGH. Leave the HSB unconnected if it is not used.





#### Hardware RECALL (Power Up)

During power up or after any low power condition ( $V_{CC}$ <br/> $V_{SWITCH}$ ), an internal RECALL request is latched. When V<sub>CC</sub> again exceeds the sense voltage of V<sub>SWITCH</sub>, a RECALL cycle is automatically initiated and takes t<sub>HRECALL</sub> to complete.

#### Software STORE

Transfer data from the SRAM to the nonvolatile memory with a software address sequence. The CY14B104L/CY14B10<u>4N</u> software STORE cycle is initiated by executing sequential CE controlled read cycles from six specific address locations in exact order. During the STORE cycle an erase of the previous nonvolatile data is first performed, followed by a program of the nonvolatile elements. After a STORE cycle is initiated, further input and output are disabled until the cycle is completed.

Because a sequence of READs from specific addresses is used for STORE initiation, it is important that no other read or write accesses intervene in the sequence, or the sequence is aborted and no STORE or RECALL takes place.

To initiate the software STORE cycle, the following read sequence must be performed.

- 1. Read Address 0x4E38 Valid READ
- 2. Read Address 0xB1C7 Valid READ
- 3. Read Address 0x83E0 Valid READ
- 4. Read Address 0x7C1F Valid READ
- 5. Read Address 0x703F Valid READ
- 6. Read Address 0x8FC0 Initiate STORE Cycle

#### Table 1. Mode Selection

The software sequence may be clocked with  $\overline{\text{CE}}$  controlled reads or  $\overline{\text{OE}}$  controlled reads. After the sixth address in the sequence is entered, the STORE cycle commences and the chip is disabled. It is important to use read cycles and not write cycles in the sequence, although it is not necessary that  $\overline{\text{OE}}$  be LOW for a valid sequence. After the t<sub>STORE</sub> cycle time is fulfilled, the SRAM is activated again for the read and write operation.

#### Software RECALL

Transfer the data from the nonvolatile memory to the SRAM with a software address sequence. A software RECALL cycle is initiated with a sequence of read operations in a manner similar to the software STORE initiation. To initiate the RECALL cycle, the following sequence of CE controlled read operations must be performed.

- 1. Read Address 0x4E38 Valid READ
- 2. Read Address 0xB1C7 Valid READ
- 3. Read Address 0x83E0 Valid READ
- 4. Read Address 0x7C1F Valid READ
- 5. Read Address 0x703F Valid READ
- 6. Read Address 0x4C63 Initiate RECALL Cycle

Internally, RECALL is a two step procedure. First, the SRAM data is cleared; then, the nonvolatile information is transferred into the SRAM cells. After the  $t_{RECALL}$  cycle time, the SRAM is again ready for read and write operations. The RECALL operation does not alter the data in the nonvolatile elements.

| CE | WE | OE | A15 - A0   | Mode  | ю  | Power                     |
|----|----|----|--|---|--|---------------------------|
| Н  | Х  | Х  | Х  | Not Selected  | Output High Z  | Standby                   |
| L  | Н  | L  | Х  | Read SRAM   | Output Data  | Active                    |
| L  | L  | Х  | Х  | Write SRAM  | Input Data   | Active                    |
| L  | Н  | L  | 0x4E38<br>0xB1C7<br>0x83E0<br>0x7C1F<br>0x703F<br>0x8B45 | Read SRAM<br>Read SRAM<br>Read SRAM<br>Read SRAM<br>Read SRAM<br>AutoStore<br>Disable | Output Data<br>Output Data<br>Output Data<br>Output Data<br>Output Data<br>Output Data | Active <sup>[4,5,6]</sup> |
| L  | Н  | L  | 0x4E38<br>0xB1C7<br>0x83E0<br>0x7C1F<br>0x703F<br>0x4B46 | Read SRAM<br>Read SRAM<br>Read SRAM<br>Read SRAM<br>Read SRAM<br>AutoStore Enable     | Output Data<br>Output Data<br>Output Data<br>Output Data<br>Output Data<br>Output Data | Active <sup>[4,5,6]</sup> |

#### Notes

- 5. While there are 19 address lines on the CY14B104L/CY14B104N, only the lower 16 lines are used to control software modes.
- 6. IO state depends on the state of OE, BHE, and BLE. The IO table shown assumes OE, BHE, and BLE LOW.

<sup>4.</sup> The six consecutive address locations must be in the order listed. WE must be HIGH during all six cycles to enable a nonvolatile cycle.



Table 1. Mode Selection (continued)

| CE | WE | OE | A15 - A0   | Mode   | ю  | Power                                      |
|----|----|----|--|--|--|--|
| L  | H  | Ĺ  | 0x4E38<br>0xB1C7<br>0x83E0<br>0x7C1F<br>0x703F<br>0x8FC0 | Read SRAM<br>Read SRAM<br>Read SRAM<br>Read SRAM<br>Read SRAM<br>Nonvolatile Store     | Output Data<br>Output Data<br>Output Data<br>Output Data<br>Output Data<br>Output High Z | Active I <sub>CC2</sub> <sup>[4,5,6]</sup> |
| L  | Н  | L  | 0x4E38<br>0xB1C7<br>0x83E0<br>0x7C1F<br>0x703F<br>0x4C63 | Read SRAM<br>Read SRAM<br>Read SRAM<br>Read SRAM<br>Read SRAM<br>Nonvolatile<br>Recall | Output Data<br>Output Data<br>Output Data<br>Output Data<br>Output Data<br>Output High Z | Active <sup>[4,5,6]</sup>                  |

#### **Preventing AutoStore**

The AutoStore function is disabled by initiating an AutoStore disable sequence. A sequence of read operations is performed in a manner similar to the software STORE initiation. To initiate the AutoStore disable sequence, the following sequence of CE controlled read operations must be performed:

- 1. Read address 0x4E38 Valid READ
- 2. Read address 0xB1C7 Valid READ
- 3. Read address 0x83E0 Valid READ
- 4. Read address 0x7C1F Valid READ
- 5. Read address 0x703F Valid READ
- 6. Read address 0x8B45 AutoStore Disable

The AutoStore is re-enabled by initiating an AutoStore enable sequence. A sequence of read operations is performed in a manner similar to the software RECALL initiation. To initiate the AutoStore enable sequence, the following sequence of  $\overline{CE}$  controlled read operations must be performed:

- 1. Read address 0x4E38 Valid READ
- 2. Read address 0xB1C7 Valid READ
- 3. Read address 0x83E0 Valid READ
- 4. Read address 0x7C1F Valid READ
- 5. Read address 0x703F Valid READ
- 6. Read address 0x4B46 AutoStore Enable

If the AutoStore function is disabled or re-enabled, a manual STORE operation (hardware or software) must be issued to save the AutoStore state through subsequent power down cycles. The part comes from the factory with AutoStore enabled.

#### **Data Protection**

The CY14B104L/CY14B104N protects data from corruption during low voltage conditions by inhibiting all externally initiated STORE and write operations. The low voltage condition is detected when  $V_{CC} < V_{SWITCH}$ . If the CY14B104L/CY14B104N is in a write mode (both CE and WE are LOW) at power up, after a RECALL or STORE, the write is inhibited until a negative transition on CE or WE is detected. This protects against inadvertent writes during power up or brown out conditions.

#### **Noise Considerations**

Refer CY application note AN1064.



# CY14B104L, CY14B104N

### **Maximum Ratings**

Exceeding maximum ratings may impair the useful life of the device. These user guidelines are not tested.

| Storage Temperature65°C to +150°C   |
|---|
| Ambient Temperature with<br>Power Applied55°C to +150°C                           |
| Supply Voltage on $V_{CC}$ Relative to GND–0.5V to 4.1V                           |
| Voltage Applied to Outputs in High-Z State–0.5V to V $_{\rm CC}$ + 0.5V           |
| Input Voltage0.5V to Vcc+0.5V   |
| Transient Voltage (<20 ns) on Any Pin to Ground Potential–2.0V to $V_{CC}$ + 2.0V |

### **DC Electrical Characteristics**

Over the Operating Range  $(V_{CC} = 2.7V \text{ to } 3.6V)^{[9]}$ 

| Package Power Dissipation<br>Capability ( $T_A = 25^{\circ}C$ ) | 1.0W     |
|---|----------|
| Surface Mount Pb Soldering<br>Temperature (3 Seconds)           | +260°C   |
| Output Short Circuit Current [7]                                | 15 mA    |
| Static Discharge Voltage<br>(per MIL-STD-883, Method 3015)      | > 2001V  |
| Latch Up Current  | > 200 mA |

### **Operating Range**

| Range      | Ambient Temperature | V <sub>CC</sub> |  |  |  |
|------------|---------------------|-----------------|--|--|--|
| Commercial | 0°C to +70°C        | 2.7V to 3.6V    |  |  |  |
| Industrial | –40°C to +85°C      | 2.7V to 3.6V    |  |  |  |

| Parameter                       | Description   | Test Conditions   |            | Min            | Max                   | Unit           |
|---------------------------------|---|---|------------|----------------|-----------------------|----------------|
| I <sub>CC1</sub>                | Average V <sub>CC</sub> Current   | $t_{RC}$ = 15 ns<br>$t_{RC}$ = 20 ns<br>$t_{RC}$ = 25 ns<br>$t_{RC}$ = 45 ns<br>Dependent on output loading and surely                                      | Commercial |                | 70<br>65<br>65<br>50  | mA<br>mA<br>mA |
|                                 |   | Dependent on output loading and cycle<br>rate.Values obtained without output loads.<br>I <sub>OUT</sub> = 0 mA  | Industrial |                | 75<br>70<br>70<br>52  | mA<br>mA<br>mA |
| I <sub>CC2</sub>                | Average V <sub>CC</sub> Current<br>during STORE                                     | All Inputs Don't Care, V <sub>CC</sub> = Max<br>Average current for duration t <sub>STORE</sub>   |            |                | 6                     | mA             |
| I <sub>CC3</sub> <sup>[8]</sup> | Average V <sub>CC</sub> Current at<br>t <sub>RC</sub> = 200 ns, 3V, 25°C<br>typical | WE > (V <sub>CC</sub> – 0.2). All other I/P cycling.<br>Dependent on output loading and cycle rate. Valu<br>without output loads.                           |            | 35             | mA                    |                |
| I <sub>CC4</sub>                |   | All Inputs Don't Care, V <sub>CC</sub> = Max<br>Average current for duration t <sub>STORE</sub>   |            | 6              | mA                    |                |
| I <sub>SB</sub>                 | V <sub>CC</sub> Standby Current   | CE > ( $V_{CC} - 0.2$ ). All others $V_{IN} < 0.2V$ or > ( $V_{CC}$<br>Standby current level after nonvolatile cycle is co<br>Inputs are static. f = 0 MHz. |            | 3              | mA                    |                |
| I <sub>IX</sub>                 | Input Le <u>aka</u> ge Current<br>(except HSB)                                      | $V_{CC} = Max, V_{SS} \le V_{IN} \le V_{CC}$  |            | -1             | +1                    | μA             |
|                                 | Inpu <u>t Lea</u> kage Current<br>(for HSB)   | $V_{CC} = Max, V_{SS} \le V_{IN} \le V_{CC}$  |            | -100           | +1                    | μA             |
| l <sub>oz</sub>                 | Off-State Output<br>Leakage Current   | $V_{CC} = Max, V_{SS} \le V_{IN} \le V_{CC}, \overline{CE} \text{ or } \overline{OE} > V_{IH}$  |            | -1             | +1                    | μA             |
| V <sub>IH</sub>                 | Input HIGH Voltage  |   |            | 2.0            | V <sub>CC</sub> + 0.5 | V              |
| V <sub>IL</sub>                 | Input LOW Voltage   |   |            | $V_{ss} - 0.5$ | 0.8                   | V              |
| V <sub>OH</sub>                 | Output HIGH Voltage   | I <sub>OUT</sub> = -2 mA  |            | 2.4            |                       | V              |
| V <sub>OL</sub>                 | Output LOW Voltage  | I <sub>OUT</sub> = 4 mA   |            |                | 0.4                   | V              |
| V <sub>CAP</sub>                | Storage Capacitor   | Between $V_{CAP}$ pin and $V_{SS}$ , 5V Rated   |            | 61             | 82                    | μF             |

#### Notes

Outputs shorted for no more than one second. Only one output shorted at a time.
 Typical conditions for the active current shown on the front page of the data sheet are average values at 25°C (room temperature), and V<sub>CC</sub> = 3V. Not 100% tested.

9. The HSB pin has I<sub>OUT</sub>=-10 uA for V<sub>OH</sub> of 2.4V.This parameter is characterized but not tested.



### Capacitance

In the following table, the capacitance parameters are listed.<sup>[10]</sup>

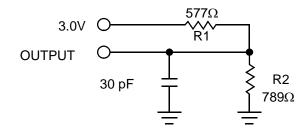
| Parameter        | Description        | Test Conditions                           | Max | Unit |
|------------------|--------------------|---|-----|------|
| C <sub>IN</sub>  | Input Capacitance  | $T_{A} = 25^{\circ}C, f = 1 \text{ MHz},$ | 7   | pF   |
| C <sub>OUT</sub> | Output Capacitance | $V_{CC} = 0$ to 3.0V                      | 7   | pF   |

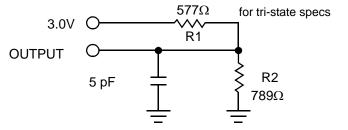
#### **Thermal Resistance**

In the following table, the thermal resistance parameters are listed. <sup>[10]</sup>

| Parameter     | Description                              | Test Conditions  | 48-FBGA | 44-TSOP II | 54-TSOP II | Unit |
|---------------|--|--|---------|------------|------------|------|
| $\Theta_{JA}$ | · /                                      | Test conditions follow standard test methods<br>and procedures for measuring thermal | 28.82   | 31.11      | 30.73      | °C/W |
| $\Theta_{JC}$ | Thermal Resistance<br>(Junction to Case) | impedance, in accordance with EIA/JESD51.  | 7.84    | 5.56       | 6.08       | °C/W |

#### Figure 5. AC Test Loads





### **AC Test Conditions**

| Input Pulse Levels                       | )V to 3V |
|--|----------|
| Input Rise and Fall Times (10% - 90%)    | <5 ns    |
| Input and Output Timing Reference Levels | 1.5V     |



## **AC Switching Characteristics**

| Paran                             | neters            |                                      | 15  | ns  | 20 ns |     | 25 ns |     | 45 ns |     |      |
|-----------------------------------|-------------------|--------------------------------------|-----|-----|-------|-----|-------|-----|-------|-----|------|
| Cypress<br>Parameters             | Alt<br>Parameters | Description                          | Min | Max | Min   | Max | Min   | Max | Min   | Max | Unit |
| SRAM Read                         | Cycle             | •                                    |     | •   | •     |     | •     |     | •     | •   |      |
| t <sub>ACE</sub>                  | t <sub>ACS</sub>  | Chip Enable Access Time              |     | 15  |       | 20  |       | 25  |       | 45  | ns   |
| t <sub>RC</sub> <sup>[11]</sup>   | t <sub>RC</sub>   | Read Cycle Time                      | 15  |     | 20    |     | 25    |     | 45    |     | ns   |
| t <sub>AA</sub> <sup>[12]</sup>   | t <sub>AA</sub>   | Address Access Time                  |     | 15  |       | 20  |       | 25  |       | 45  | ns   |
| t <sub>DOE</sub>                  | t <sub>OE</sub>   | Output Enable to Data Valid          |     | 10  |       | 10  |       | 12  |       | 20  | ns   |
| t <sub>OHA</sub>                  | t <sub>OH</sub>   | Output Hold After Address<br>Change  | 3   |     | 3     |     | 3     |     | 3     |     | ns   |
| t <sub>LZCE</sub> <sup>[13]</sup> | t <sub>LZ</sub>   | Chip Enable to Output Active         | 3   |     | 3     |     | 3     |     | 3     |     | ns   |
| t <sub>HZCE</sub> <sup>[13]</sup> | t <sub>HZ</sub>   | Chip Disable to Output Inactive      |     | 7   |       | 8   |       | 10  |       | 15  | ns   |
| t <sub>LZOE</sub> <sup>[13]</sup> | t <sub>OLZ</sub>  | Output Enable to Output Active       | 0   |     | 0     |     | 0     |     | 0     |     | ns   |
| t <sub>HZOE</sub> <sup>[13]</sup> | t <sub>OHZ</sub>  | Output Disable to Output<br>Inactive |     | 7   |       | 8   |       | 10  |       | 15  | ns   |
| t <sub>PU</sub> <sup>[10]</sup>   | t <sub>PA</sub>   | Chip Enable to Power Active          | 0   |     | 0     |     | 0     |     | 0     |     | ns   |
| t <sub>PD</sub> <sup>[10]</sup>   | t <sub>PS</sub>   | Chip Disable to Power Standby        |     | 15  |       | 20  |       | 25  |       | 45  | ns   |
| t <sub>DBE</sub>                  | -                 | Byte Enable to Data Valid            |     | 10  |       | 10  |       | 12  |       | 20  | ns   |
| t <sub>LZBE</sub>                 | -                 | Byte Enable to Output Active         | 0   |     | 0     |     | 0     |     | 0     |     | ns   |
| t <sub>HZBE</sub>                 | -                 | Byte Disable to Output Inactive      |     | 7   |       | 8   |       | 10  |       | 15  | ns   |
| SRAM Write                        | e Cycle           |                                      |     |     |       |     |       |     |       |     |      |
| t <sub>WC</sub>                   | t <sub>WC</sub>   | Write Cycle Time                     | 15  |     | 20    |     | 25    |     | 45    |     | ns   |
| t <sub>PWE</sub>                  | t <sub>WP</sub>   | Write Pulse Width                    | 10  |     | 15    |     | 20    |     | 30    |     | ns   |
| t <sub>SCE</sub>                  | t <sub>CW</sub>   | Chip Enable To End of Write          | 15  |     | 15    |     | 20    |     | 30    |     | ns   |
| t <sub>SD</sub>                   | t <sub>DW</sub>   | Data Setup to End of Write           | 5   |     | 8     |     | 10    |     | 15    |     | ns   |
| t <sub>HD</sub>                   | t <sub>DH</sub>   | Data Hold After End of Write         | 0   |     | 0     |     | 0     |     | 0     |     | ns   |
| t <sub>AW</sub>                   | t <sub>AW</sub>   | Address Setup to End of Write        | 10  |     | 15    |     | 20    |     | 30    |     | ns   |
| t <sub>SA</sub>                   | t <sub>AS</sub>   | Address Setup to Start of Write      | 0   |     | 0     |     | 0     |     | 0     |     | ns   |
| t <sub>HA</sub>                   | t <sub>WR</sub>   | Address Hold After End of Write      | 0   |     | 0     |     | 0     |     | 0     |     | ns   |
| t <sub>HZWE</sub> [13,14]         | t <sub>WZ</sub>   | Write Enable to Output Disable       |     | 7   |       | 8   |       | 10  |       | 15  | ns   |
| t <sub>LZWE</sub> <sup>[13]</sup> | t <sub>OW</sub>   | Output Active after End of Write     | 3   |     | 3     |     | 3     |     | 3     |     | ns   |
| t <sub>BW</sub>                   | -                 | Byte Enable to End of Write          | 15  |     | 15    |     | 20    |     | 30    |     | ns   |
|                                   |                   | 1                                    |     |     |       | •   |       | •   |       |     |      |

Note<u>s</u>

11. WE must be HIGH during SRAM read cycles.
12. Device is continuously selected with CE and OE both LOW.
13. Measured ±200 mV from steady state output voltage.
14. If WE is low when CE goes low, the outputs remain in the high impedance state.



### AutoStore/Power Up RECALL

| Parameters                           | Description               | CY14B104L | Unit |      |
|--------------------------------------|---------------------------|-----------|------|------|
| Farameters                           | Description               | Min       | Max  | onit |
| t <sub>HRECALL</sub> <sup>[15]</sup> | Power Up RECALL Duration  |           | 20   | ms   |
| t <sub>STORE</sub> <sup>[16]</sup>   | STORE Cycle Duration      |           | 15   | ms   |
| V <sub>SWITCH</sub>                  | Low Voltage Trigger Level |           | 2.65 | V    |
| t <sub>VCCRISE</sub>                 | VCC Rise Time             | 150       |      | μs   |

### Software Controlled STORE/RECALL Cycle

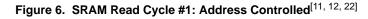
In the following table, the software controlled STORE/RECALL cycle parameters are listed.<sup>[17, 18]</sup>

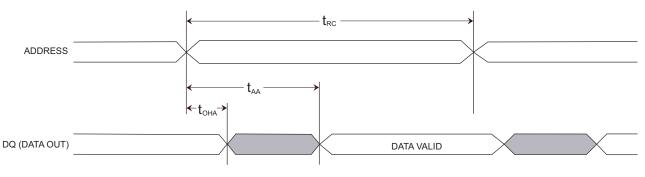
| Parameters                          | Description                        | 15 ns |     | 20 ns |     | 25 ns |     | 45 ns |     | Unit |
|-------------------------------------|------------------------------------|-------|-----|-------|-----|-------|-----|-------|-----|------|
| Farameters                          | Description                        | Min   | Max | Min   | Max | Min   | Max | Min   | Max | Onit |
| t <sub>RC</sub>                     | STORE/RECALL Initiation Cycle Time | 15    |     | 20    |     | 25    |     | 45    |     | ns   |
| t <sub>AS</sub>                     | Address Setup Time                 | 0     |     | 0     |     | 0     |     | 0     |     | ns   |
| t <sub>CW</sub>                     | Clock Pulse Width                  | 12    |     | 15    |     | 20    |     | 30    |     | ns   |
| t <sub>GHAX</sub>                   | Address Hold Time                  | 1     |     | 1     |     | 1     |     | 1     |     | ns   |
| t <sub>RECALL</sub>                 | RECALL Duration                    |       | 200 |       | 200 |       | 200 |       | 200 | μS   |
| t <sub>SS</sub> <sup>[19, 20]</sup> | Soft Sequence Processing Time      |       | 70  |       | 70  |       | 70  |       | 70  | μs   |

#### Hardware STORE Cycle

| Parameters                         | Description                         | CY14B104L | Unit |      |  |
|------------------------------------|-------------------------------------|-----------|------|------|--|
|                                    | Description                         | Min       | Max  | Onit |  |
| t <sub>DELAY</sub> <sup>[21]</sup> | Time Allowed to Complete SRAM Cycle | 1         | 70   | μS   |  |
| t <sub>HLHX</sub>                  | Hardware STORE Pulse Width          | 15        |      | ns   |  |

#### Switching Waveforms



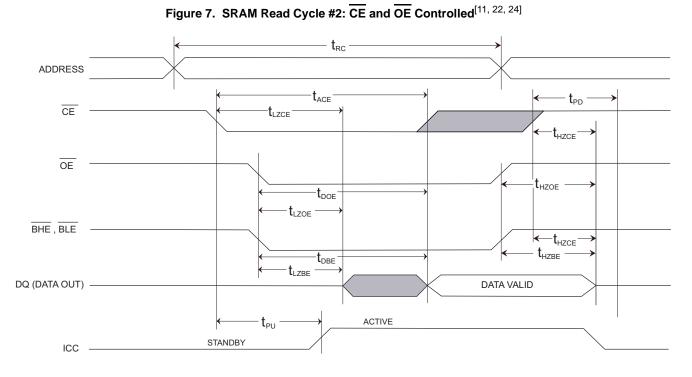


#### Notes

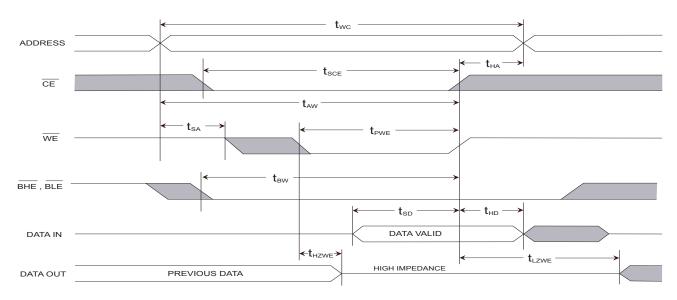
- t<sub>HRECALL</sub> starts from the time V<sub>CC</sub> rises above V<sub>SWITCH</sub>.
   If an SRAM write has not taken place since the last nonvolatile cycle, no STORE takes place.
- 17. The software sequence is clocked with  $\overline{CE}$  controlled or  $\overline{OE}$  controlled reads.
- 18. The six consecutive addresses must be read in the order listed in Table 1 on page 5. WE must be HIGH during all six consecutive cycles.
- 19. This is the amount of time it takes to take action on a soft sequence command. Vcc power must remain HIGH to effectively register command.
- 20. Commands such as STORE and RECALL lock out IO until operation is complete which further increases this time. See the specific command
- 21. On a hardware STORE initiation, SRAM operation continues to be enabled for time t<sub>DELAY</sub> to allow read and write cycles to complete.

22. HSB must remain HIGH during READ and WRITE cycles.







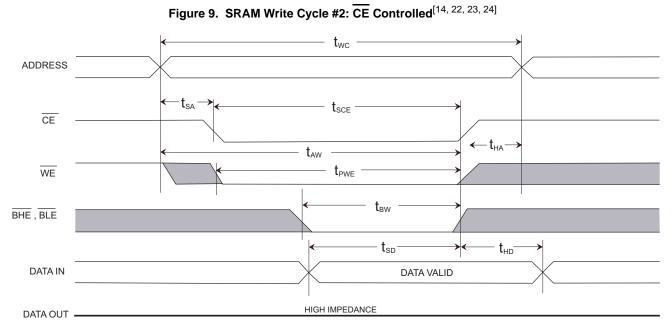


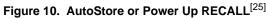
Notes\_ 23. <u>CE or WE mu</u>st be ≥V<sub>IH</sub> during address transitions. 24. BHE and BLE are applicable for x16 configuration only.

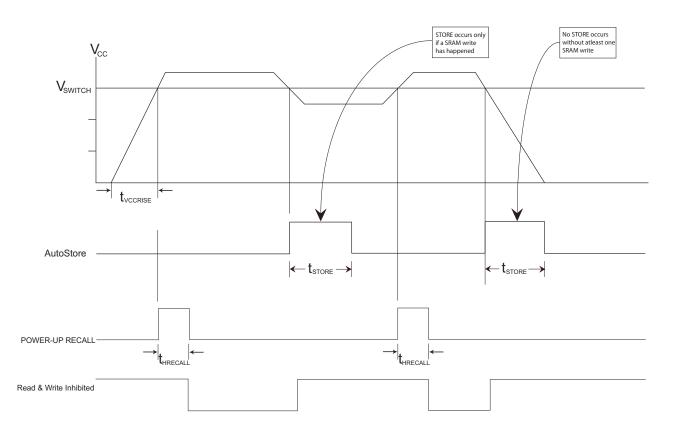
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#### Note

25. Read and Write cycles are ignored during STORE, RECALL, and while VCC is below V<sub>SWITCH</sub>.

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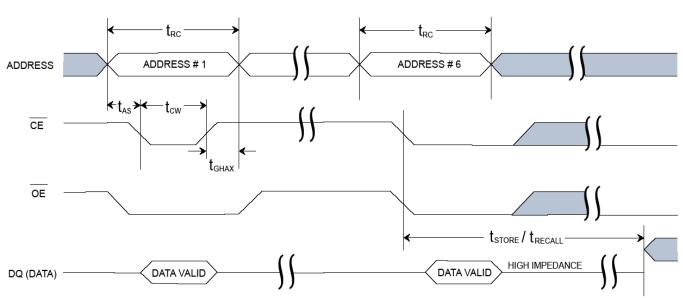
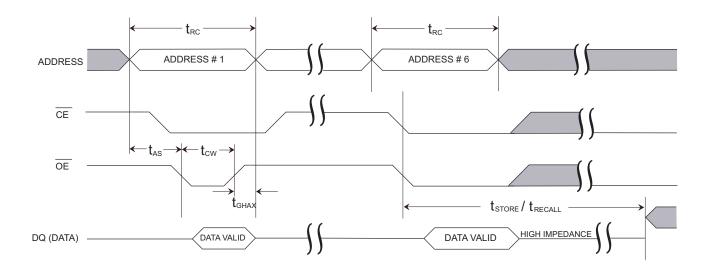


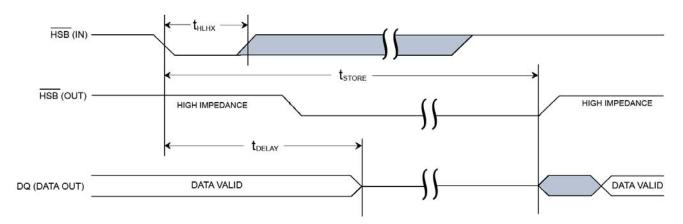
Figure 12. OE Controlled Software STORE/RECALL Cycle<sup>[18]</sup>



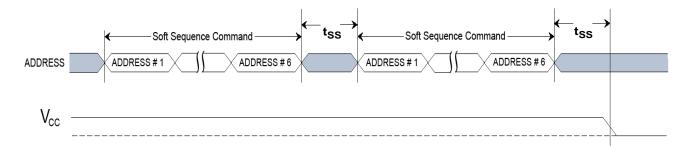














# **Ordering Information**

| Speed<br>(ns) | Ordering Code      | Package<br>Diagram | Package Type   | Operating<br>Range |
|---------------|--------------------|--------------------|----------------|--------------------|
| 15            | CY14B104LA-ZS15XCT | 51-85087           | 44-pin TSOP II | Commercial         |
|               | CY14B104L-ZS15XIT  | 51-85087           | 44-pin TSOP II | Industrial         |
|               | CY14B104L-ZS15XI   | 51-85087           | 44-pin TSOP II |                    |
|               | CY14B104L-BA15XCT  | 51-85128           | 48-ball FBGA   | Commercial         |
|               | CY14B104L-BA15XIT  | 51-85128           | 48-ball FBGA   | Industrial         |
|               | CY14B104L-BA15XI   | 51-85128           | 48-ball FBGA   |                    |
|               | CY14B104L-ZSP15XCT | 51-85160           | 54-pin TSOP II | Commercial         |
|               | CY14B104L-ZSP15XIT | 51-85160           | 54-pin TSOP II | Industrial         |
|               | CY14B104L-ZSP15XI  | 51-85160           | 54-pin TSOP II |                    |
|               | CY14B104N-ZS15XCT  | 51-85087           | 44-pin TSOP II | Commercial         |
|               | CY14B104N-ZS15XIT  | 51-85087           | 44-pin TSOP II | Industrial         |
|               | CY14B104N-ZS15XI   | 51-85087           | 44-pin TSOP II |                    |
|               | CY14B104N-BA15XCT  | 51-85128           | 48-ball FBGA   | Commercial         |
|               | CY14B104N-BA15XIT  | 51-85128           | 48-ball FBGA   | Industrial         |
|               | CY14B104N-BA15XI   | 51-85128           | 48-ball FBGA   |                    |
|               | CY14B104N-ZSP15XCT | 51-85160           | 54-pin TSOP II | Commercial         |
|               | CY14B104N-ZSP15XIT | 51-85160           | 54-pin TSOP II | Industrial         |
|               | CY14B104N-ZSP15XI  | 51-85160           | 54-pin TSOP II |                    |
| 20            | CY14B104LA-ZS20XCT | 51-85087           | 44-pin TSOP II | Commercial         |
|               | CY14B104L-ZS20XIT  | 51-85087           | 44-pin TSOP II | Industrial         |
|               | CY14B104L-ZS20XI   | 51-85087           | 44-pin TSOP II |                    |
|               | CY14B104L-BA20XCT  | 51-85128           | 48-ball FBGA   | Commercial         |
|               | CY14B104L-BA20XIT  | 51-85128           | 48-ball FBGA   | Industrial         |
|               | CY14B104L-BA20XI   | 51-85128           | 48-ball FBGA   |                    |
|               | CY14B104L-ZSP20XCT | 51-85160           | 54-pin TSOP II | Commercial         |
|               | CY14B104L-ZSP20XIT | 51-85160           | 54-pin TSOP II | Industrial         |
|               | CY14B104L-ZSP20XI  | 51-85160           | 54-pin TSOP II |                    |
|               | CY14B104N-ZS20XCT  | 51-85087           | 44-pin TSOP II | Commercial         |
|               | CY14B104N-ZS20XIT  | 51-85087           | 44-pin TSOP II | Industrial         |
|               | CY14B104N-ZS20XI   | 51-85087           | 44-pin TSOP II |                    |
|               | CY14B104N-BA20XCT  | 51-85128           | 48-ball FBGA   | Commercial         |
|               | CY14B104N-BA20XIT  | 51-85128           | 48-ball FBGA   | Industrial         |
|               | CY14B104N-BA20XI   | 51-85128           | 48-ball FBGA   |                    |
|               | CY14B104N-ZSP20XCT | 51-85160           | 54-pin TSOP II | Commercial         |
|               | CY14B104N-ZSP20XIT | 51-85160           | 54-pin TSOP II | Industrial         |
|               | CY14B104N-ZSP20XI  | 51-85160           | 54-pin TSOP II |                    |

PRELIMINARY



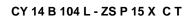
### Ordering Information (continued)

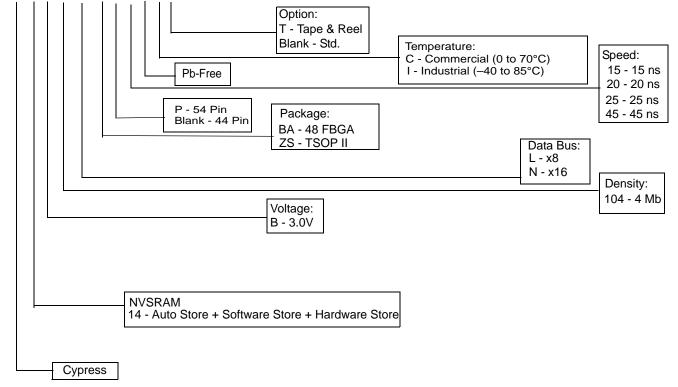
| Speed<br>(ns) | Ordering Code      | Package<br>Diagram | Package Type   | Operating<br>Range |
|---------------|--------------------|--------------------|----------------|--------------------|
| 25            | CY14B104L-ZS25XCT  | 51-85087           | 44-pin TSOP II | Commercial         |
|               | CY14B104L-ZS25XIT  | 51-85087           | 44-pin TSOP II | Industrial         |
|               | CY14B104L-ZS25XI   | 51-85087           | 44-pin TSOP II |                    |
|               | CY14B104L-BA25XIT  | 51-85128           | 48-ball FBGA   | Industrial         |
|               | CY14B104L-BA25XI   | 51-85128           | 48-ball FBGA   |                    |
|               | CY14B104N-BA25XCT  | 51-85128           | 48-ball FBGA   | Commercial         |
|               | CY14B104L-ZSP25XCT | 51-85160           | 54-pin TSOP II | Commercial         |
|               | CY14B104L-ZSP25XIT | 51-85160           | 54-pin TSOP II | Industrial         |
|               | CY14B104L-ZSP25XI  | 51-85160           | 54-pin TSOP II |                    |
|               | CY14B104N-ZS25XCT  | 51-85087           | 44-pin TSOP II | Commercial         |
|               | CY14B104N-ZS25XIT  | 51-85087           | 44-pin TSOP II | Industrial         |
|               | CY14B104N-ZS25XI   | 51-85087           | 44-pin TSOP II |                    |
|               | CY14B104N-BA25XCT  | 51-85128           | 48-ball FBGA   | Commercial         |
|               | CY14B104N-BA25XIT  | 51-85128           | 48-ball FBGA   | Industrial         |
|               | CY14B104N-BA25XI   | 51-85128           | 48-ball FBGA   |                    |
|               | CY14B104N-ZSP25XCT | 51-85160           | 54-pin TSOP II | Commercial         |
|               | CY14B104N-ZSP25XIT | 51-85160           | 54-pin TSOP II | Industrial         |
|               | CY14B104N-ZSP25XI  | 51-85160           | 54-pin TSOP II |                    |
| 45            | CY14B104L-ZS45XCT  | 51-85087           | 44-pin TSOP II | Commercial         |
|               | CY14B104L-ZS45XIT  | 51-85087           | 44-pin TSOP II | Industrial         |
|               | CY14B104L-ZS45XI   | 51-85087           | 44-pin TSOP II |                    |
|               | CY14B104L-BA45XCT  | 51-85128           | 48-ball FBGA   | Commercial         |
|               | CY14B104L-BA45XIT  | 51-85128           | 48-ball FBGA   | Industrial         |
|               | CY14B104L-BA45XI   | 51-85128           | 48-ball FBGA   |                    |
|               | CY14B104L-ZSP45XCT | 51-85160           | 54-pin TSOP II | Commercial         |
|               | CY14B104L-ZSP45XIT | 51-85160           | 54-pin TSOP II | Industrial         |
|               | CY14B104L-ZSP45XI  | 51-85160           | 54-pin TSOP II |                    |
|               | CY14B104N-ZS45XCT  | 51-85087           | 44-pin TSOP II | Commercial         |
|               | CY14B104N-ZS45XIT  | 51-85087           | 44-pin TSOP II | Industrial         |
|               | CY14B104N-ZS45XI   | 51-85087           | 44-pin TSOP II |                    |
|               | CY14B104N-BA45XCT  | 51-85128           | 48-ball FBGA   | Commercial         |
|               | CY14B104N-BA45XIT  | 51-85128           | 48-ball FBGA   | Industrial         |
|               | CY14B104N-BA45XI   | 51-85128           | 48-ball FBGA   |                    |
|               | CY14B104N-ZSP45XCT | 51-85160           | 54-pin TSOP II | Commercial         |
|               | CY14B104N-ZSP45XIT | 51-85160           | 54-pin TSOP II | Industrial         |
|               | CY14B104N-ZSP45XI  | 51-85160           | 54-pin TSOP II |                    |

All parts are Pb-free. The above table contains Preliminary information. Please contact your local Cypress sales representative for availability of these parts.



### Part Numbering Nomenclature



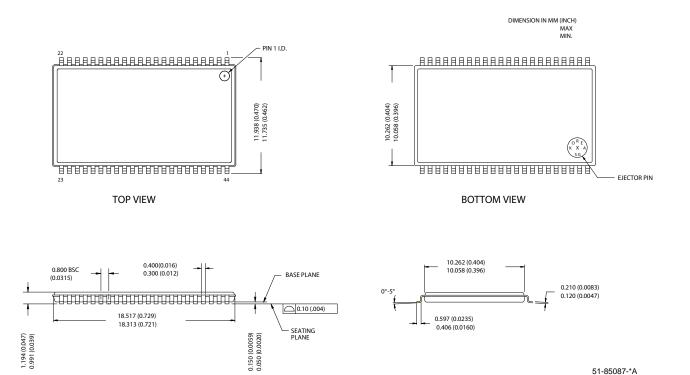






# Package Diagrams

Figure 15. 44-Pin TSOP II (51-85087)

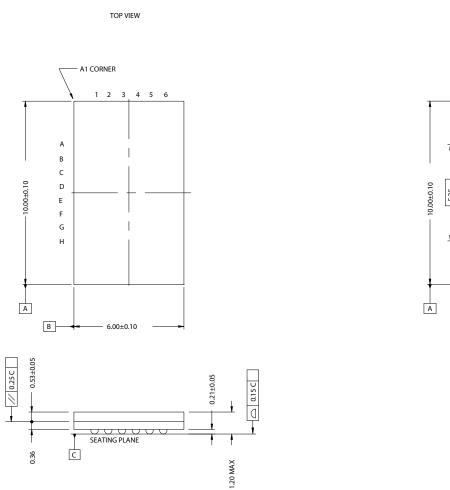


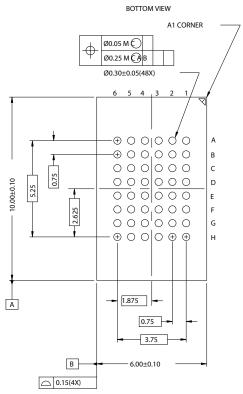
51-85087-\*A



### Package Diagrams (continued)





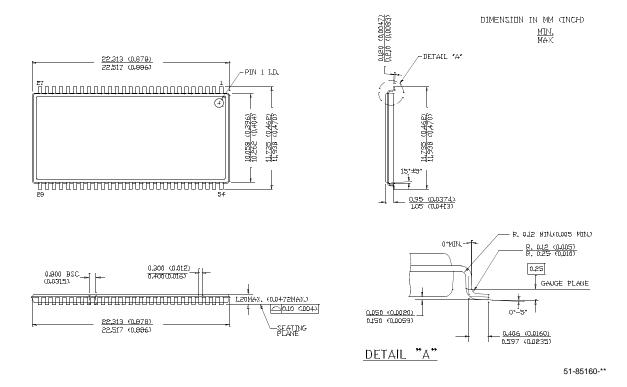


51-85128-\*D



### Package Diagrams (continued)

#### Figure 17. 54-Pin TSOP II (51-85160)





# **Document History Page**

|      | Document Title: CY14B104L/CY14B104N 4 Mbit (512K x 8/256K x 16) nvSRAM<br>Document Number: 001-07102 |                    |                    |   |  |  |  |  |
|------|--|--------------------|--------------------|---|--|--|--|--|
| Rev. | ECN No.  | Submission<br>Date | Orig. of<br>Change | Description of Change   |  |  |  |  |
| **   | 431039   | See ECN            | TUP                | New Data Sheet  |  |  |  |  |
| *A   | 489096   | See ECN            | TUP                | Removed 48 SSOP Package<br>Added 48 FBGA and 54 TSOPII Packages<br>Updated Part Numbering Nomenclature and Ordering Information<br>Added Soft Sequence Processing Time Waveform   |  |  |  |  |
| *B   | 499597   | See ECN            | PCI                | Removed 35 ns speed bin<br>Added 55 ns speed bin. Updated AC table for the same<br>Changed "Unlimited" read/write to "infinite" read/write<br>Features section: Changed typical I <sub>CC</sub> at 200-ns cycle time to 8 mA<br>Changed STORE cycles from 500K to 200K cycles<br>Shaded Commercial grade in operating range table<br>Modified Icc/Is specs<br>48 FBGA package nomenclature changed from BW to BV<br>Modified part nomenclature table. Changes reflected in ordering information table   |  |  |  |  |
| *C   | 517793   | See ECN            | TUP                | Removed 55ns speed bin<br>Changed pinout for 44TSOPII and 54TSOPII packages<br>Changed $I_{SB}$ to 1mA<br>Changed $I_{CC4}$ to 3mA<br>Changed $V_{CAP}$ min to 35 $\mu$ F<br>Changed $V_{IH}$ max to Vcc + 0.5V<br>Changed $I_{STORE}$ to 15ms<br>Changed $I_{STORE}$ to 15ms<br>Changed $I_{SCE}$ to 15ns<br>Changed $I_{SCE}$ to 15ns<br>Changed $I_{SD}$ to 5ns<br>Changed $I_{HLBL}$<br>Added Timing Parameters for BHE and BLE - $I_{DBE}$ , $I_{LZBE}$ , $I_{HZBE}$ , $I_{BW}$<br>Removed $I_{HLBL}$<br>Added Timing Parameters for Vswitch<br>Changed $I_{GLAX}$ to 1ns<br>Added $I_{DELAY}$ max of 70us<br>Changed $I_{SS}$ specification from 70us min to 70us max |  |  |  |  |
| *D   | 774001   | See ECN            | UHA                | Changed the data sheet from Advance information to Preliminary<br>48 FBGA package code changed from BV to BA<br>Removed 48 FBGA package in X8 configuration in ordering information.<br>Changed t <sub>DBE</sub> to 10ns in 15ns part<br>Changed t <sub>HZBE</sub> in 15ns part to 7ns and in 25ns part to10ns<br>Changed t <sub>BW</sub> in 15ns part to 15ns and in 25ns part to 20ns<br>Changed t <sub>GLAX</sub> to t <sub>GHAX</sub><br>Changed the value of I <sub>CC3</sub> to 25mA<br>Changed the value of t <sub>AW</sub> in 15ns part to15ns<br>Changed A <sub>18</sub> and A <sub>19</sub> Pins in FBGA Pin Configuration to NC                                  |  |  |  |  |
| *E   | 914220   | See ECN            | UHA                | Included all the information for 45 ns part in this data sheet  |  |  |  |  |



|      | Document Title: CY14B104L/CY14B104N 4 Mbit (512K x 8/256K x 16) nvSRAM<br>Document Number: 001-07102 |                    |                    |   |  |  |  |  |
|------|--|--------------------|--------------------|---|--|--|--|--|
| Rev. | ECN No.  | Submission<br>Date | Orig. of<br>Change | Description of Change   |  |  |  |  |
| *F   | 1889928  | See ECN            | vsutmp8/<br>AESA   | Added Footnotes 1, 2 and 3.<br>Updated logic block diagram<br>Added 48-FBGA (X8) Pin Diagram<br>Changed 8Mb Address expansion Pin from Pin 43 to Pin 42 for 44-TSOP II (x8).<br>Updated pin definitions table.<br>Corrected typo in $V_{IL}$ min spec<br>Changed the value of $I_{CC3}$ from 25mA to 13mA<br>Changed I <sub>SB</sub> value from 1mA to 2mA<br>Rearranging of Footnotes.<br>Updated ordering information table   |  |  |  |  |
| *G   | 2267286  | See ECN            | GVCH/P<br>YRS      | Added $\overline{\text{BHE}}$ and $\overline{\text{BLE}}$ Information in Pin Definitions Table<br>Updated Figure 4 (Autostore mode)<br>Updated footnote 6<br>Changed I <sub>CC2</sub> & I <sub>CC4</sub> from 3 mA to 6 mA<br>Changed I <sub>CC3</sub> from 13 mA to 15 mA<br>Changed Vcap from 35uF min and 57uF max value to 54uF min and 82uF max value<br>Changed I <sub>SB</sub> from 2 mA to 3 mA<br>Added input leakage current (I <sub>IX</sub> ) for HSB in DC Electrical Characteristics table<br>Corrected typo in t <sub>DBE</sub> value from 22 ns to 20 ns for 45 ns part<br>Corrected typo in t <sub>HZBE</sub> value from 15 ns to 10ns for 15 ns part<br>Corrected typo in t <sub>AW</sub> value from 15 ns to 10ns for 15 ns part<br>Changed t <sub>RECALL</sub> from 100 to 200 us<br>Added footnotes 9 and 25; Reframed footnote 14 and 21<br>Added footnote 14 to figure 7 (SRAM WRITE Cycle #1) |  |  |  |  |
| *H   | 2483627  | See ECN            | GVCH/P<br>YRS      | Removed 8 mA typical I <sub>CC</sub> at 200 ns cycle time in Feature section<br>Referenced footnote 8 to I <sub>CC3</sub> in DC Characteristics table<br>Changed I <sub>CC3</sub> from 15 mA to 35 mA<br>Changed Vcap minimum value from 54 uF to 61 uF<br>Changed t <sub>AVAV</sub> to t <sub>RC</sub><br>Figure 11:Changed t <sub>SA</sub> to t <sub>AS</sub> and t <sub>SCE to</sub> t <sub>CW</sub>   |  |  |  |  |



| Document Title: CY14B104L/CY14B104N 4 Mbit (512K x 8/256K x 16) nvSRAM<br>Document Number: 001-07102 |         |                    |                    |   |  |  |  |
|--|---------|--------------------|--------------------|---|--|--|--|
| Rev.   | ECN No. | Submission<br>Date | Orig. of<br>Change | Description of Change   |  |  |  |
| *  | 2519319 | 06/20/08           | GVCH/P<br>YRS      | Added 20 ns access speed in "Features"<br>Added $I_{CC1}$ for $t_{RC}$ =20 ns for both industrial and Commecial temperature Grade<br>updated Thermal resistance table values for 48-FBGA, 44-TSOP II and 54-TSOP II<br>Packages<br>Added AC Switching Characteristics specs for 20 ns access speed<br>Added software controlled STORE/RECALL cycle specs for 20 ns access speed<br>Updated ordering information and part numbering nomenclature |  |  |  |

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